Docket No. 241677US2

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

GAU:

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IN RE APPLICATION OF: Kenji YOSHIDA, et al.		GAU:	
SERIAL NO: New Application		EXAMINER:	
FILED: Herewith			
FOR: METHOD OF ACCELER	OR: METHOD OF ACCELERATING TEST OF SEMICONDUCTOR DEVICE		
	REQUEST FOR PRIOR	RITY	
COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313			
SIR:			
☐ Full benefit of the filing date of U.S. provisions of 35 U.S.C. §120.	•	is claimed pursuant to the	
☐ Full benefit of the filing date(s) of U.S. Provisional Application(s) is claimed pursuant to the provisions of 35 U.S.C. §119(e): <u>Application No.</u> <u>Date Filed</u>			
Applicants claim any right to prior the provisions of 35 U.S.C. §119,	ity from any earlier filed applicat as noted below.	ions to which the	ey may be entitled pursuant to
In the matter of the above-identified ap	pplication for patent, notice is here	eby given that the	e applicants claim as priority:
<u>COUNTRY</u> Japan	APPLICATION NUMBER 2002-238032		TH/DAY/YEAR 19, 2002
Certified copies of the corresponding C	Convention Application(s)		
are submitted herewith	. Cd. P' .1P		
will be submitted prior to paym			
<ul> <li>□ were filed in prior application Serial No.</li> <li>□ were submitted to the International Bureau in PCT Application Number</li> </ul>			
Receipt of the certified copies lacknowledged as evidenced by	by the International Bureau in a ti	imely manner un	der PCT Rule 17.1(a) has been
☐ (A) Application Serial No.(s) were filed in prior application Serial No. filed ; and			
☐ (B) Application Serial No.(s)			
are submitted herewith			
☐ will be submitted prior t	o payment of the Final Fee		
	Respectfully Submitted,		
		MAIER & NEU	
1.100 (10 1/2/3 )   DOT 1879   ENGL 891/ 1881		film	nMGrlun
		Marvin J. Spivak	
22850		Registration No.	24,913
440JU			

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